

August 1989 Revised August 2000

100302

Low Power Quint 2-Input OR/NOR Gate

General Description

The 100302 is a monolithic quint 2-input OR/NOR gate with common enable. All inputs have 50 k Ω pull-down resistors and all outputs are buffered.

Features

- 43% power reduction of the 100102
- 2000V ESD protection
- Pin/function compatible with 100102
- Voltage compensated operating range = -4.2V to -5.7V
- Available to industrial grade temperature range (PLCC package only)

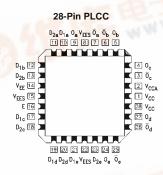
Ordering Code:

Order Number	Package Number	Package Description
100302SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
100302PC	N24E	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.400 Wide
100302QC	V28A	28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square
100302QI		28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Industrial Temperature Range (-40°C to +85°C)

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagrams



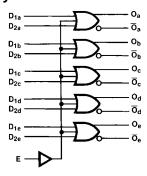


Pin Descriptions

Pin Names	Description
D _{na} -D _{ne}	Data Inputs
E -35 177	Enable Input
O _a -O _e	Data Outputs
$\frac{O_a-O_e}{\overline{O}_a-\overline{O}_e}$	Complementary Data Outputs



Logic Symbol



Truth Table

D _{1X}	D _{2X}	E	o _x	ō _x
L	L	L	L	Н
L	L	Н	Н	L
L	Н	L	Н	L
L	Н	Н	Н	L
Н	L	L	Н	L
Н	L	Н	Н	L
Н	Н	L	Н	L
Н	Н	Н	Н	L

H = HIGH Voltage Level

L = LOW Voltage Level

Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

Case Temperature (T_C)

 $\begin{tabular}{lll} Commercial & 0°C to +85°C \\ Industrial & -40°C to +85°C \\ Supply Voltage (V_{EE}) & -5.7V to -4.2V \\ \end{tabular}$

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Commercial Version

DC Electrical Characteristics (Note 3)

 $\rm V_{EE} = -4.2V$ to $-5.7V,~V_{CC} = V_{CCA} = GND,~T_{C} = 0^{\circ}C$ to $+85^{\circ}C$

Symbol	Parameter	Min	Тур	Max	Units	Conditions			
V _{OH}	Output HIGH Voltage	-1025	-955	-870	mV	Variation of Variation	Loading with		
V _{OL}	Output LOW Voltage	-1830	-1705	-1620	mV	$V_{IN} = V_{IH(Max)}$ or $V_{IL(Min)}$	50Ω to $-2.0V$		
V _{OHC}	Output HIGH Voltage	-1035			mV	$V_{IN} = V_{IH(Min)}$ or $V_{IL(Max)}$	Loading with		
V _{OLC}	Output LOW Voltage			-1610	mV	VIN - VIH(Min) Of VIL(Max)	50Ω to $-2.0V$		
V _{IH}	Input HIGH Voltage	-1165		-870	mV	Guaranteed HIGH Signal for All Inputs	3		
V _{IL}	Input LOW Voltage	-1830		-1475	mV	Guaranteed LOW Signal for All Inputs			
I _{IL}	Input LOW Current	0.50			μΑ	$V_{IN} = V_{IL(Min)}$			
I _{IH}	Input HIGH Current			240	μΑ	$V_{IN} = V_{IH(Max)}$			
I _{EE}	Power Supply Current	-45	-36	-20	mA	Inputs OPEN			

Note 3: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

DIP AC Electrical Characteristics

 $V_{EE} = -4.2V \text{ to } -5.7V, V_{CC} = V_{CCA} = GND$

Symbol	Parameter	$T_C = 0^{\circ}C$		$T_C = +25^{\circ}C$		$T_C = +85^{\circ}C$		Units	Conditions
		Min	Max	Min	Max	Min	Max	Units	Conditions
t _{PLH}	Propagation Delay	0.50	1.15	0.50	1.15	0.50	1.25	ns	
t _{PHL}	Data to Output	0.50	1.13	0.50	1.13	0.50	1.25	115	Figures 1, 2
t _{PLH}	Propagation Delay	0.70	1.90	0.70	1.90	0.80	2.00	ns	(Note 4)
t _{PHL}	Enable to Output	0.70	1.90	0.70	1.90	0.60	2.00	115	
t _{TLH}	Transition Time	0.40	1.20	0.40	1.20	0.40	1.20	ns	Figures 1, 2
t _{THL}	20% to 80%, 80% to 20%	0.40	1.20	0.40	1.20	0.40	1.20	115	rigules 1, 2

Note 4: The propagation delay specified is for single output switching. Delays may vary up to 100 ps with multiple outputs switching.

Commercial Version (Continued) SOIC and PLCC AC Electrical Characteristics

 $V_{EF} = -4.2V$ to -5.7V, $V_{CC} = V_{CCA} = GND$

Symbol	Parameter	T _C = 0°C		T _C = -	⊦25°C	T _C = +85°C		Units	Conditions
Symbol		Min	Max	Min	Max	Min	Max	Units	Conditions
PLH	Propagation Delay	0.50	1.05	0.50	1.05	0.50	1.15	ns	
PHL	Data to Output	0.50	1.05	0.50	1.05	0.50	1.15	115	Figures 1, 2
PLH	Propagation Delay	0.70	1.80	0.70	1.80	0.80	1.90	ns	(Note 5)
PHL	Enable to Output	0.70	1.00	0.70	1.00	0.80	1.50	115	
ΓLH	Transition Time	0.40	1.10	0.40	1.10	0.40	1.10	ns	Figures 1, 2
THL	20% to 80%, 80% to 20%	0.40	1.10	0.40	1.10	0.40	1.10	115	rigules 1, 2
OSHL	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		250		250		250	ps	(Note 6)
	Data to Output Path								
OSHL	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		310		310		310	ps	(Note 6)
	Enable to Output Path								
OSLH	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		200		200		200	ps	(Note 6)
	Data to Output Path								
OSLH	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		330		330		330	ps	(Note 6)
	Enable to Output Path								
OST	Maximum Skew Opposite Edge								PLCC Only
	Output-to-Output Variation		250		250		250	ps	(Note 6)
	Data to Output Path								
OST	Maximum Skew Opposite Edge								PLCC Only
	Output-to-Output Variation		330		330		330	ps	((Note 6)
	Enable to Output Path								
PS	Maximum Skew								PLCC Only
	Pin (Signal) Transition Variation		200		200		200	ps	(Note 6)
	Data to Output Path								
'S	Maximum Skew								PLCC Only
	Pin (Signal) Transition Variation		280		280		280	ps	(Note 6)
	Enable to Output Path								

Note 5: The propagation delay specified is for single output switching. Delays may vary up to 100 ps with multiple outputs switching.

Note 6: Output-to-Output Skew is defined as the absolute value of the difference between the actual propagation delay for any outputs within the same packaged device. The specifications apply to any outputs switching in the same direction either HIGH-to-LOW (t_{OSHL}), or LOW-to-HIGH (t_{OSLH}), or in opposite directions both HL and LH (t_{OST}). Parameters t_{OST} and t_{PS} guaranteed by design.

Industrial Version

PLCC DC Electrical Characteristics (Note 7) V_{EE} = -4.2V to -5.7V, V_{CC} = V_{CCA} = GND, T_C = -40°C to +85°C

Symbol	Parameter	Parameter $T_C = -40^{\circ}C$ $T_C = 0^{\circ}C$ to $+85^{\circ}C$ Un		Units	Conditions				
- Cy20.	i aramete.	Min	Max	Min	Max	• • • • • • • • • • • • • • • • • • • •	•		
V _{OH}	Output HIGH Voltage	-1085	-870	-1025	-870	mV	$V_{IN} = V_{IH(Max)}$	Loading with	
V _{OL}	Output LOW Voltage	-1830	-1575	-1830	-1620		or V _{IL(Min)}	50Ω to $-2.0V$	
V _{OHC}	Output HIGH Voltage	-1095		-1035		- mV	$V_{IN} = V_{IH(Min)}$	Loading with	
V _{OLC}	Output LOW Voltage		-1565		-1610	IIIV	or V _{IL(Max)}	50Ω to $-2.0V$	
V _{IH}	Input HIGH Voltage	-1170	-870	-1165	-870	mV	Guaranteed HIGH Signal fo	or ALL Inputs	
V _{IL}	Input LOW Voltage	-1830	-1480	-1830	-1475	mV	Guaranteed LOW Signal fo	r ALL Inputs	
I_{IL}	Input LOW Current	0.05		0.05		μΑ	$V_{IN} = V_{IL(Min)}$		
I _{IH}	Input HIGH Current		300		240	μΑ	$V_{IN} = V_{IH(Max)}$		
I _{EE}	Power Supply Current	-45	-20	-45	-20	mA	Inputs OPEN		

Note 7: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under the "worst case" conditions.

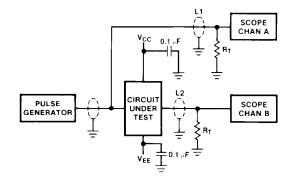
PLCC AC Electrical Characteristics

 $V_{EE} = -4.2V$ to -5.7V, $V_{CC} = V_{CCA} = GND$

Symbol	Parameter	$T_C = -40^{\circ}C$		$T_C = +25^{\circ}C$		$T_C = +85^{\circ}C$		Units	Conditions
Cymbol	. arailletei	Min	Max	Min	Max	Min	Max	Omits	Conditions
t _{PLH}	Propagation Delay	0.40	1.05	0.50	1.05	0.50	1.15	ns	
t _{PHL}	Data to Output	0.40	1.05	0.50	1.05	0.50	1.13	115	Figures 1, 2
t _{PLH}	Propagation Delay	0.70	1.80	0.70	1.80	0.80	1.90	ns	(Note 8)
t _{PHL}	Enable to Output	0.70	1.00	0.70	1.00	0.00	1.90	115	
t _{TLH}	Transition Time	0.30	1.10	0.40	1.10	0.40	1.10	ns	Figures 1, 2
t _{THL}	20% to 80%, 80% to 20%	0.30	1.10	0.40	1.10	0.40	1.10	115	Figures 1, 2

Note 8: The propagation delay specified is for single output switching. Delays may vary up to 200 ps with multiple outputs switching.

Test Circuitry



Notes:

 $V_{CC},\,V_{CCA}=+2V,\,V_{EE}=-2.5V$

L1 and L2 = equal length 50Ω impedance lines

 $R_T = 50\Omega$ terminator internal to scope

Decoupling 0.1 μF from GND to V_{CC} and V_{EE}

All unused outputs are loaded with 50Ω to GND

 $C_L = Fixture$ and stray capacitance $\leq 3 \ pF$

FIGURE 1. AC Test Circuit

Switching Waveforms

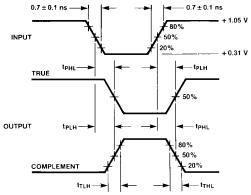
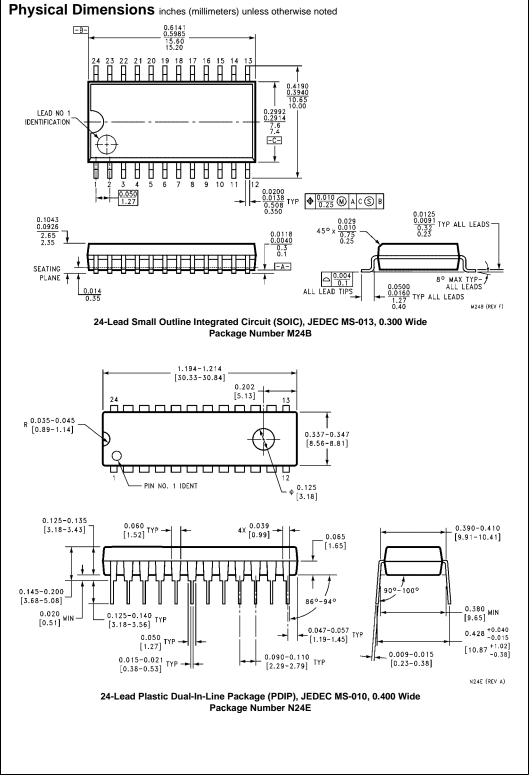
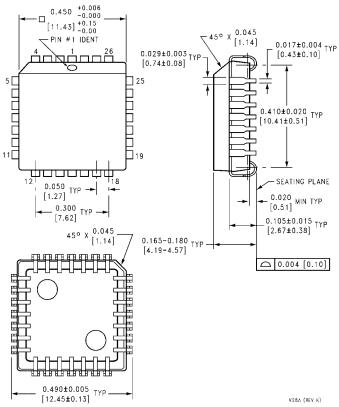


FIGURE 2. Propagation Delay and Transition Times



Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Package Number V28A

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